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**PART NUMBER****54AC05**

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**Rochester Electronics  
Manufactured Components**

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer. (OCM)

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

**Quality Overview**

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
  - Class Q Military
  - Class V Space Level

**Qualified Suppliers List of Distributors (QSLD)**

- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

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*The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.*

# 54AC05

## Hex Inverter with Open Drain Outputs

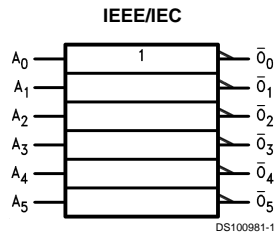
### General Description

The 'AC05 contains six inverters.

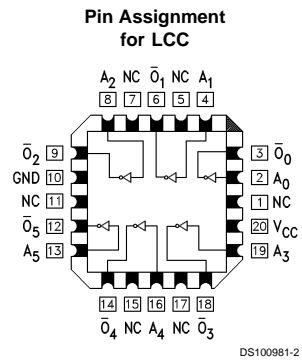
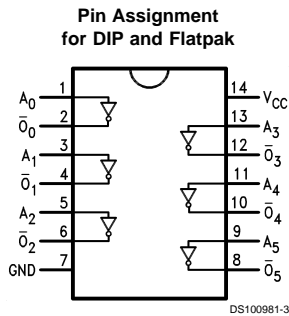
### Features

- Outputs sink 24 mA
- Open drain for wired NOR function
- Standard Microcircuit Drawing (SMD) 5962-9059001

### Logic Symbol



### Connection Diagrams



Pin Names	Description
$A_n$	Inputs
$\bar{O}_n$	Outputs

FACT™ is a trademark of Fairchild Semiconductor Corporation.

### Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage ( $V_{CC}$ )	-0.5V to +7.0V
DC Input Diode Current ( $I_{IK}$ )	
$V_I = -0.5V$	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage ( $V_I$ )	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current ( $I_{OK}$ )	
$V_O = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage ( $V_O$ )	-0.5V to to $V_{CC} + 0.5V$
DC Output Source or Sink Current ( $I_O$ )	±50 mA
DC $V_{CC}$ or Ground Current per Output Pin ( $I_{CC}$ or $I_{GND}$ )	±50 mA

Storage Temperature ( $T_{STG}$ )	-65°C to +150°C
Junction Temperature ( $T_J$ )	
CDIP	175°C

### Recommended Operating Conditions

Supply Voltage ( $V_{CC}$ )	'AC	2.0V to 6.0V
Input Voltage ( $V_I$ )		0V to $V_{CC}$
Output Voltage ( $V_O$ )		0V to $V_{CC}$
Operating Temperature ( $T_A$ )	54AC	-55°C to +125°C
Minimum Input Edge Rate ( $\Delta V/\Delta t$ )	$V_{IN}$ from 30% to 70% of $V_{CC}$	
	$V_{CC}$ @ 3.3V, 4.5V, 5.5V	125 mV/ns

**Note 1:** Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT® circuits outside databook specifications.

### DC Characteristics for 'AC Family Devices

Symbol	Parameter	$V_{CC}$ (V)	54AC	Units	Conditions
			$T_A = -55^\circ\text{C to } +125^\circ\text{C}$		
			Guaranteed Limits		
$V_{IH}$	Minimum High Level Input Voltage	3.0	2.1	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	3.15		
		5.5	3.85		
$V_{IL}$	Maximum Low Level Input Voltage	3.0	0.9	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	1.35		
		5.5	1.65		
$V_{OL}$	Maximum Low Level Output Voltage	3.0	0.1	V	$I_{OUT} = 50 \mu A$
		4.5	0.1		
		5.5	0.1		
		3.0	0.5	V	(Note 2) $V_{IN} = V_{IL}$ or $V_{IH}$ 12 mA $I_{OL}$ 24 mA 24 mA
		4.5	0.5		
	5.5	0.5			
$I_{IN}$	Maximum Input Leakage Current	5.5	±1.0	µA	$V_I = V_{CC}, GND$
$I_{OHC}$	Output Leakage Current High	5.5	-10.0	µA	$V_{IN} = V_{CC}$
$I_{OLD}$	Minimum Dynamic Output Current	5.5	50.0	mA	$V_{OLD} = 1.65V$ Max (Note 3)
$I_{CC}$	Maximum Quiescent Supply Current	5.5	80.0	µA	$V_{IN} = V_{CC}$ or GND

**Note 2:** All outputs loaded; thresholds on input associated with output under test.

**Note 3:** Maximum test duration 2.0 ms, one output loaded at a time.

## AC Electrical Characteristics

Symbol	Parameter	V <sub>CC</sub> (V) (Note 4)	54AC		Units	Fig. No.
			T <sub>A</sub> = -55°C to +125°C C <sub>L</sub> = 50 pF			
			Min	Max		
t <sub>PLH</sub>	Propagation Delay	3.3	1.0	15.5	ns	
		5.0	1.0	15.5		
t <sub>PHL</sub>	Propagation Delay	3.3	1.0	8.0	ns	
		5.0	1.5	6.0		

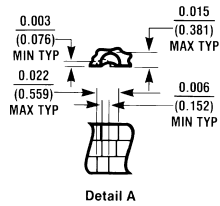
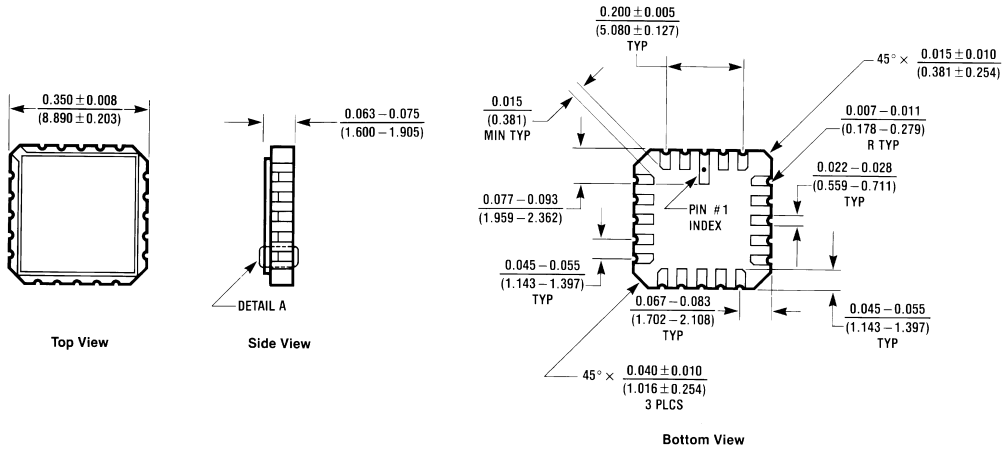
**Note 4:** Voltage Range 3.3 is 3.3V ±0.3V  
Voltage Range 5.0 is 5.0V ±0.5V

## Capacitance

Symbol	Parameter	Max	Units	Conditions
C <sub>IN</sub>	Input Capacitance	10.0	pF	V <sub>CC</sub> = Open
C <sub>PD</sub>	Power Dissipation Capacitance	50.0	pF	V <sub>CC</sub> = 5.0V

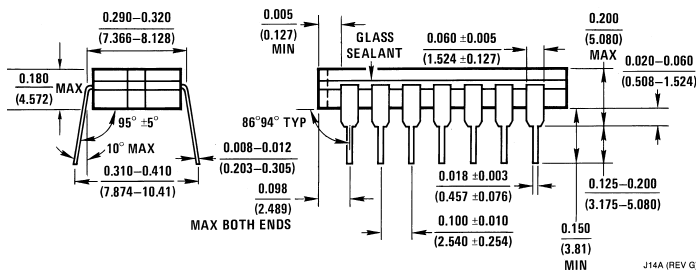
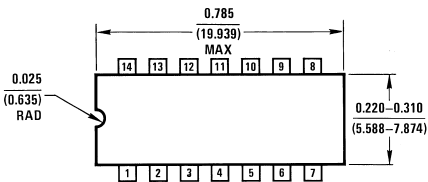


**Physical Dimensions** inches (millimeters) unless otherwise noted



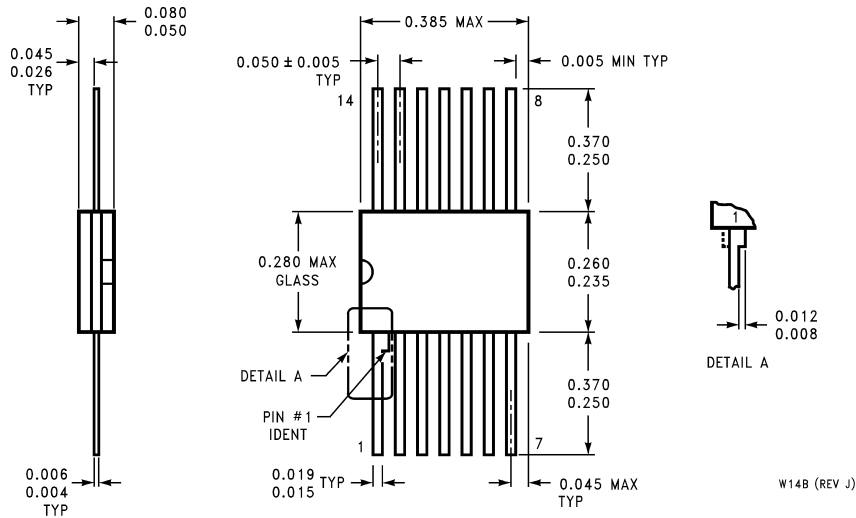
**20 Terminal Ceramic Leadless Chip Carrier (L)**  
 NS Package Number E20A

E20A (REV D)



**14 Lead Ceramic Dual-In-Line Package (D)**  
 NS Package Number J14A

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



**14 Lead Ceramic Flatpak (F)  
NS Package Number W14B**

W14B (REV J)

**LIFE SUPPORT POLICY**

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.



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